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| Notice of References Cited | Application/Control No. 10/078,475 | Applicant(s)/Patent Under Reexamination BAN ET AL. | |
| | Examiner Mike Tomaszewski | Art Unit 3626 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-5,557,514 A | 09-1996 | Seare et al. | 705/2 |
| * | B | US-5,613,072 A | 03-1997 | Hammond et al. | 705/4 |
| * | C | US-5,937,387 A | 08-1999 | Summerell et al. | 705/2 |
| * | D | US-6,059,724 A | 05-2000 | Campell et al. | 600/300 |
| * | E | US-6,283,761 B1 | 09-2001 | Joao, Raymond Anthony | 434/236 |
| * | F | US-6,569,093 B2 | 05-2003 | Iliff, Edwin C. | 600/300 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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